

**Search Notes**

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Examiner

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Applicant(s)/Patent under  
Reexamination

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Art Unit

2683

**SEARCHED**

Class	Subclass	Date	Examiner
455	449	2/14/2006	CH.
455	444	2/14/2006	CH.
455	456.6	2/14/2006	CH.
455	422.1	2/14/2006	CH.

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Class/Subclass/ICombined Text	2/9/2006	CH.
Citations/IDS	2/9/2006	CH.